

Notice of References Cited	Application/Control No. 10/584,890		Applicant(s)/Patent Under Reexamination SHIN CHIN ET AL.	
	Examiner DAVID B. LUGO		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,391,715	06-2008	Lee et al.	370/208
*	B	US-2004/0071118	04-2004	Dabak et al.	370/335
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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